## Surface Scattering via Bulk Continuum States in the 3D Topological Insulator Bi<sub>2</sub>Se<sub>3</sub>

Sunghun Kim,<sup>1</sup> M. Ye,<sup>1</sup> K. Kuroda,<sup>1</sup> Y. Yamada,<sup>1</sup> E. E. Krasovskii,<sup>2,3,4</sup> E. V. Chulkov,<sup>2,3</sup> K. Miyamoto,<sup>5</sup> M. Nakatake,<sup>5</sup>

T. Okuda,<sup>5</sup> Y. Ueda,<sup>6</sup> K. Shimada,<sup>5</sup> H. Namatame,<sup>5</sup> M. Taniguchi,<sup>1,5</sup> and A. Kimura<sup>1,\*</sup>

<sup>1</sup>Graduate School of Science, Hiroshima University, 1-3-1 Kagamiyama, Higashi-Hiroshima 739-8526, Japan

<sup>2</sup>Departamento de Física de Materiales UPV/EHU and Centro de Física de Materiales CFM—MPC

and Centro Mixto CSIC-UPV/EHU, 20080 San Sebastián/Donostia, Basque Country, Spain

<sup>3</sup>Donostia International Physics Center (DIPC), 20018 San Sebastián/Donostia, Basque Country, Spain

<sup>4</sup>IKERBASQUE, Basque Foundation for Science, 48011 Bilbao, Spain

<sup>5</sup>Hiroshima Synchrotron Radiation Center, Hiroshima University, 2-313 Kagamiyama, Higashi-Hiroshima 739-0046, Japan

<sup>6</sup>Kure National College of Technology, Agaminami 2-2-11, Kure 737-8506, Japan

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We have performed scanning tunneling microscopy and differential tunneling conductance (dI/dV) mapping for the surface of the three-dimensional topological insulator Bi<sub>2</sub>Se<sub>3</sub>. The fast Fourier transformation applied to the dI/dV image shows an electron interference pattern near Dirac node despite the general belief that the backscattering is well suppressed in the bulk energy gap region. The comparison of the present experimental result with theoretical surface and bulk band structures shows that the electron interference occurs through the scattering between the surface states near the Dirac node and the bulk continuum states.

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Recent discovery of topological insulators has aroused great attention to the new state of quantum matter originating from the surface state that forms a massless Dirac cone centered at time-reversal invariant momentum [1–12]. Unlike the spin-degenerate Dirac fermions in graphene, this novel electronic state possesses helical spin textures protected by time-reversal symmetry, which creates the potential for spintronics devices without heat dissipation and for quantum computation applications. The topological insulator phase has been predicted to exist in a number of three-dimensional materials,  $Bi_{1-x}Sb_x$  [10],  $Bi_2Se_3$ ,  $Bi_2Te_3$ , and  $Sb_2Te_3$  [11]. The spin-helical surface states have been experimentally observed by angle-resolved photoelectron spectroscopy (ARPES) [5,7–9], also with spin resolution [6,12,13].

Among the binary chalcogenides,  $Bi_2Se_3$  is regarded as the most promising candidate owing to the single ideal Dirac cone residing in a wide band gap (0.3 eV). Therefore, significant effort has been applied towards the realization of spintronics devices using the quantum topological transport in  $Bi_2Se_3$  [14–17]. The magnetotransport measurements showed Shubnikov–de Haas oscillations originating from the 3D Fermi surface, but no surface contribution to conduction has been observed in 3D topological insulators even at low carrier density [15–17].

These observations pose the question of what limits the surface electron conduction in  $Bi_2Se_3$ . Band structure calculations of Ref. [7] predict the Dirac point of the surface state in  $Bi_2Se_3$  to be located below or close to the bulk valence band maximum, which may open a scattering channel from the surface states to bulk continuum states [7]. In this Letter, we present scanning tunneling

microscopy evidence of the near-surface scattering of the spin polarized surface states at the Dirac point in  $Bi_2Se_3$  into spin-degenerate bulk continuum states.

The scanning tunneling microscopy (STM) and spectroscopy (STS) experiments were conducted at 78 K and at 4.5 K in an ultrahigh vacuum with a base pressure of  $1 \times 10^{-10}$  mbar using a low-temperature scanning tunneling microscope (LT-STM, Omicron NanoTechnology). The STM images were acquired in the constant-current mode with a bias voltage  $V_s$  applied to the sample. The dI/dV images were obtained simultaneously by recording the STM images using a lock-in technique. Bi<sub>2</sub>Se<sub>3</sub> samples were cleaved *in situ* at room temperature in an ultrahigh vacuum to minimize the surface contamination. For comparison, a photoemission spectrum was measured with a hemispherical photoelectron analyzer (VG-SCIENTA R4000) at Hiroshima Synchrotron Radiation Center, Hiroshima University. The crystal structure of Bi<sub>2</sub>Se<sub>3</sub> consists of weakly bonded 5-layer (quintuple layer) blocks composed of Se-Bi-Se-Bi-Se atomic layers. Therefore, the topmost Se layer is exposed to the ultrahigh vacuum.

The STM topographic image and the dI/dV map acquired at 78 K for the sample bias voltage  $V_s = -300$  mV are shown in Figs. 1(a) and 1(b). We find two different defect images with clover- and triangular-shaped patterns superimposed on the atomically resolved periodic structure spreading over the entire surface area in the topographic STM image. In the dI/dV image of Fig. 1(b) the clovershaped pattern can still be seen, but not the triangular one. If we take a close look at the clover-shaped pattern in Fig. 1(c), we find the intensity modulation near the defect with a much longer wavelength than the surface lattice



FIG. 1 (color online). (a) STM and (b) differential conductance images of  $Bi_2Se_3$  surface at a sample bias voltage of -300 mV (10 nm  $\times$  10 nm). (c) Expanded image of the clover-shaped pattern of (b) (5 nm  $\times$  5 nm). (d) Fast Fourier transformation image of (c). All data sets are taken at a temperature of 78 K.

constant. A similar pattern has been observed in the pioneering STM study [18] and identified as a defect state induced by an excess Bi atom substituting the bottom Se site of the topmost quintuple layer. It was suggested that a resonance state is formed inside the bulk valence band due to the defect. Since the concept of topological insulator was not established at that time, we now need to revisit and reconsider the origin of the peculiar pattern in the STM image by taking into account the presence of the Dirac fermions with helical spin texture.

In Fig. 1(d) we show the fast Fourier transformation (FFT) of the dI/dV image. Here the surface Brillouin zone (SBZ) boundaries are drawn from the obtained sharp FFT spots originated from the surface periodicity. The FFT image unambiguously tells us that an electron interference takes place as is seen from the flower-shaped intensity distribution [Fig. 1(d)]. The maximal intensity is seen to be along the  $\overline{\Gamma} \overline{M}$  direction of the scattering vector **q**, exhibiting a node in the  $\overline{\Gamma} \overline{K}$  direction.

In order to further reveal the electron interference effect around the defects in Bi<sub>2</sub>Se<sub>3</sub>, we have performed the experiment at a liquid He temperature (4.5 K). Figure 2 shows the experimental local density of states (LDOS) measured as the differential tunneling conductance dI/dV (STS) spectrum of Bi<sub>2</sub>Se<sub>3</sub> surface. We find a V-shaped STS spectrum with a minimum at -300 mVrelative to the Fermi energy ( $E_F$ ), which corresponds to the Dirac point (DP). The slope of STS spectrum is seen to become much steeper below -500 mV and above  $E_F$ . By comparing the present STS spectrum with the reported ARPES energy dispersion [9], we find the bulk valence band (BVB) onset at -500 mV leading to the



FIG. 2 (color online). Experimental local density of states of  $Bi_2Se_3$  surface acquired at 4.5 K (*lower*). Corresponding energy dispersion curve measured by ARPES for the surface state of  $Bi_2Se_3$  is shown for comparison (*upper*). Both are shown in the same energy scale and their energy axes are fixed at the Dirac point.

enhancement of LDOS below this energy. The shoulder at -100 meV coincides with the onset of bulk conduction band (BCB) as shown in Fig. 2.

Figures 3(a)–3(i) represent the differential tunneling conductance dI/dV images from  $V_s = -600$  to -150 mV in the 50 nm × 50 nm scanning area. Here the clover-shaped defect again appears with a brighter contrast with respect to the rest part of the images in a limited bias window between -450 and -300 mV [Figs. 3(c)–3(f)], which is close to and a little below the DP. However, it loses contrast at higher voltages ( $V_s > -250$  mV) and becomes even darker at  $V_s < -500$  mV [Figs. 3(a) and 3(b)].

To quantify the observed electron interference effect and determine the relevant q values, the FFT has been applied to the dI/dV images in Figs. 4(a)-4(i). At first, we observe a characteristic continuous intensity distribution with sixfold symmetry inside the SBZ for  $V_s = -450$ , -400, -350, and -300 mV, for which the clover-shaped patterns are observed in the corresponding dI/dV images [Figs. 4(c)-4(f)]. Of the four FFT images, the intensity is the most prominent at  $V_s = -400$  and -350 mV, which coincides with the most distinct contrast in the clovershaped pattern in Fig. 3(d) and 3(e). The characteristic sixfold pattern disappears above -250 mV, where only a weak intensity remains around the SBZ center [Figs. 4(g)-4(i)]. Below -450 mV, the FFT patterns become less anisotropic and their intensity is weakened as the bias voltage decreases. It follows from the FFT analysis that the anisotropic interference is strongest between -450 and -300 mV, i.e., close to and slightly below the Dirac point.



FIG. 3 (color online). (a)–(i) Differential conductance images of  $Bi_2Se_3$  surface at 4.5 K for several sample bias voltages from -600 to -150 mV in the area of 50 nm  $\times$  50 nm.

To gain deeper insight into the origin of the unexpected interference pattern, the cross-sectional FFT patterns traced along  $\overline{\Gamma} \overline{M}$  direction are shown in Fig. 4(j). For the whole range of sample bias voltages, we observe the largest intensity at q = 0, which might originate from several extrinsic factors, such as a background noise whose modulation length would be much longer than the characteristic wavelength of the surface lattice periodicity and the electron interference.

On the topological insulator surface, the spins are locked with momenta, giving rise to helical Dirac fermions with lifted spin degeneracy. Owing to the strictly antiparallel spins at  $-\mathbf{k}$  and  $\mathbf{k}$ , surface electrons are protected from backscattering, and no standing wave pattern arising from the interference with the backscattered wave can be observed for a single Dirac cone. On the other hand, there might be other scattering channels within the surface state cone with a finite parallel spin component, which could contribute to the scattering with small **q** values of less than  $0.2 \text{ Å}^{-1}$  (the maximal radius of the cone is  $0.1 \text{ Å}^{-1}$ ). Although a detailed structure of surface state scattering is not resolved in the present data, the dominant contribution around  $\mathbf{q} = 0$  apparently originates from the extrinsic effect because a finite intensity at  $\mathbf{q} = 0$  persists and even enhances below -500 mV, where the surface states are merged into the bulk valence band.

Let us now consider broad humps centered at  $q = \pm 0.3 \text{ Å}^{-1}$ , which are especially pronounced in the sample bias range from -450 to -300 mV as indicated by vertical bars in Fig. 4(j). The intensities in this cross-sectional FFT profile are spread over a wide interval  $-0.5 < q < 0.5 \text{ Å}^{-1}$ . Note that the FFT pattern is anisotropic, i.e., the intensity vanishes in the  $\overline{\Gamma} \overline{K}$  direction, see Figs. 4(c)-4(f). The observed magnitude of the scattering vector,  $|q| \sim 0.3 \text{ Å}^{-1}$ , is too large to be explained by a scattering within the Dirac cone, especially near the DP. Besides, the profile



FIG. 4 (color online). (a)–(i) Fast Fourier transformation of the dI/dV images in Figs. 3(a)–3(i) for respective bias voltages. (j) Cross-sectional profiles of the FFT images for (a)–(i) along  $\overline{\Gamma} \overline{M}$ . (k) Theoretical surface state dispersion (solid lines) and  $\mathbf{k}_{\parallel}$  projected bulk band structure (shaded area). An arrow shows possible surface to bulk scattering channels.

is too broad to be explained by a scattering between the surface states well localized in  $\mathbf{k}_{\parallel}$ . Also note that the intensity maxima of the hump are nearly independent of the bias voltage. Another important observation is that the hump almost disappears at 50 mV above the DP, which also excludes its origin from the surface state scattering. Since the scattering occurs at the near-surface defect, we need to consider both surface and bulk band structure to figure out a possible scattering channel other than the surface states of the Dirac cone.

We have performed a first principles calculation of the surface states with a slab of 7 f.u. with a two-component self-consistent (within the local density approximation) full-potential augmented plane wave method [19]. According to the theoretical band structure the DP is energetically located slightly below the bulk valence band maximum in the middle of the  $\overline{\Gamma} \overline{M}$  interval, whereas around the  $\overline{\Gamma}$  point the bulk band gap widens, so the states of the Dirac cone are energetically well separated from the bulk states with small  $\mathbf{k}_{\parallel}$  vectors [Fig. 4(k)]. The interference between a surface state with the lateral Bloch vector  $k^{\it s}_{\parallel}$  and a bulk state with  $k^{\it b}_{\parallel}$  caused by the scattering at the point defect results in spatial oscillations of LDOS with the wave vector  $\mathbf{q} = \mathbf{k}_{\parallel}^{s} - \mathbf{k}_{\parallel}^{b}$ . The possible  $s \rightarrow b$  transitions at the DP energy are seen to be centered at  $q \approx 0.3 \text{ Å}^{-1}$  in the  $\overline{\Gamma}\overline{M}$  direction. At the same time, in the  $\overline{\Gamma}\overline{K}$  direction such transitions are forbidden in a wide energy interval: the valence band maximum is located much lower in energy than in the  $\Gamma \overline{M}$  direction. This striking anisotropy explains the negligible FFT intensity along  $\overline{\Gamma} \overline{K}$  line, which results in the flower-shaped distribution in Fig. 4. Since the bulk states are continuously distributed over the surface perpendicular momentum the interference pattern broadens, leading to a smeared hump in Fig. 4(j). Between the valence band maximum and the conduction band minimum there exists a large portion of the upper cone that does not energetically overlap with bulk states. This is consistent with the abrupt disappearance of the hump above  $V_s =$ -200 mV [Fig. 4(j)]. This means that the surface-bulk scattering is strongly suppressed above the DP, which supports our interpretation of the hump at  $q \approx 0.3 \text{ Å}^{-1}$ as due to the scattering into bulk states. A similar scattering may also occur via the bulk conduction band for  $V_{\rm s} > -100 \text{ meV}$  with a smaller scattering vector  $|q| \leq$  $0.2 \text{ Å}^{-1}$ , which is beyond the resolution limit of this measurement. Most probably, it is this process that gives rise to the triangular-shaped pattern in Fig. 1, as it appears in the topographic image and disappears in the dI/dV map.

In summary, we have shown by scanning tunneling microscopy and differential tunneling conductance measurements that a strong surface state—bulk continuum scattering occurs near the Dirac node at the surface of the three-dimensional topological insulator  $Bi_2Se_3$ , contrary to the belief that the surface state in the bulk energy

gap around  $\overline{\Gamma}$  point is protected from scattering [7]. This may have implications for the construction of spintronic devices. In particular, it has been proposed to tune the DP at the top and the bottom surfaces of a thin film below and above the chemical potential in the dual-gate device configuration [20]. To suppress the scattering one would have to separate both the lower and the upper Dirac cone from the bulk states. Also, in order to realize the anomalous Hall effect by an appropriate magnetic doping, one must precisely tune the chemical potential right at the Dirac point to achieve the surface insulating state by opening the energy gap [21]. Thus, we expect the present results to stimulate future band engineering in order to isolate the Dirac surface state from the bulk continuum and facilitate topological quantum transport.

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\*akiok@hiroshima-u.ac.jp

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